

## IGBT<sup>3</sup> Chip

### Features:

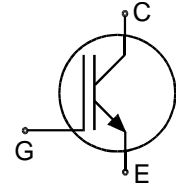
- 600V Trench & Field Stop technology
- low  $V_{CE(sat)}$
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

### This chip is used for:

- power module
- discrete components

### Applications:

- drives
- white goods
- resonant applications



Chip Type	$V_{CE}$	$I_C$	Die Size	Package
SIGC04T60GE	600V	6A	1.89 x 2.17 mm <sup>2</sup>	sawn on foil

### Mechanical Parameters

Raster size	1.89 x 2.17	mm <sup>2</sup>
Emitter pad size (incl. gate pad)	1.007 x 1.33	
Gate pad size	0.361 x 0.513	
Area total	4.1	
Thickness	70	µm
Wafer size	200	mm
Max.possible chips per wafer	6841	
Passivation frontside	Photoimide	
Pad metal	3200 nm AlSiCu	
Backside metal	Ni Ag –system suitable for epoxy and soft solder die bonding	
Die bond	Electrically conductive glue or solder	
Wire bond	Al, <500µm	
Reject ink dot size	Ø 0.65mm ; max 1.2mm	
Recommended storage environment	Store in original container, in dry nitrogen, in dark environment, < 6 month at an ambient temperature of 23°C	

## Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-Emitter voltage, $T_{vj}=25\text{ °C}$	$V_{CE}$	600	V
DC collector current, limited by $T_{vj\text{ max}}$	$I_C$	1)	A
Pulsed collector current, $t_p$ limited by $T_{vj\text{ max}}$	$I_{C,puls}$	18	A
Gate emitter voltage	$V_{GE}$	±20	V
Junction temperature range	$T_{vj}$	-40 ... +175	°C
Operating junction temperature	$T_{vj}$	-40...+150	°C
Short circuit data <sup>2)</sup> $V_{GE} = 15V, V_{CC} = 360V, T_{vj} = 150\text{ °C}$	$t_{SC}$	6	µs
Reverse bias safe operating area <sup>2)</sup> (RBSOA)	$I_{C,max} = 12A, V_{CE,max} = 600V$ $T_{vj} \leq 150\text{ °C}$		

<sup>1)</sup> depending on thermal properties of assembly

<sup>2)</sup> not subject to production test - verified by design/characterization

## Static Characteristics (tested on wafer), $T_{vj}=25\text{ °C}$

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-Emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE}=0V, I_C=2\text{ mA}$	600			V
Collector-Emitter saturation voltage	$V_{CEsat}$	$V_{GE}=15V, I_C=6A$	1.1	1.5	1.9	
Gate-Emitter threshold voltage	$V_{GE(th)}$	$I_C=90\mu A, V_{GE}=V_{CE}$	5.0	5.8	6.5	
Zero gate voltage collector current	$I_{CES}$	$V_{CE}=600V, V_{GE}=0V$			0.4	µA
Gate-Emitter leakage current	$I_{GES}$	$V_{CE}=0V, V_{GE}=20V$			300	nA
Integrated gate resistor	$r_G$			--		Ω

## Dynamic Characteristics (not subject to production test - verified by design / characterization),

$T_{vj}=25\text{ °C}$

Parameter	Symbol	Conditions	Value			Unit
			min.	Typ.	max.	
Input capacitance	$C_{ies}$	$V_{CE}=25V,$ $V_{GE}=0V,$ $f=1\text{ MHz}$		368		pF
Output capacitance	$C_{oes}$			28		
Reverse transfer capacitance	$C_{res}$			11		



# SIGC04T60GE

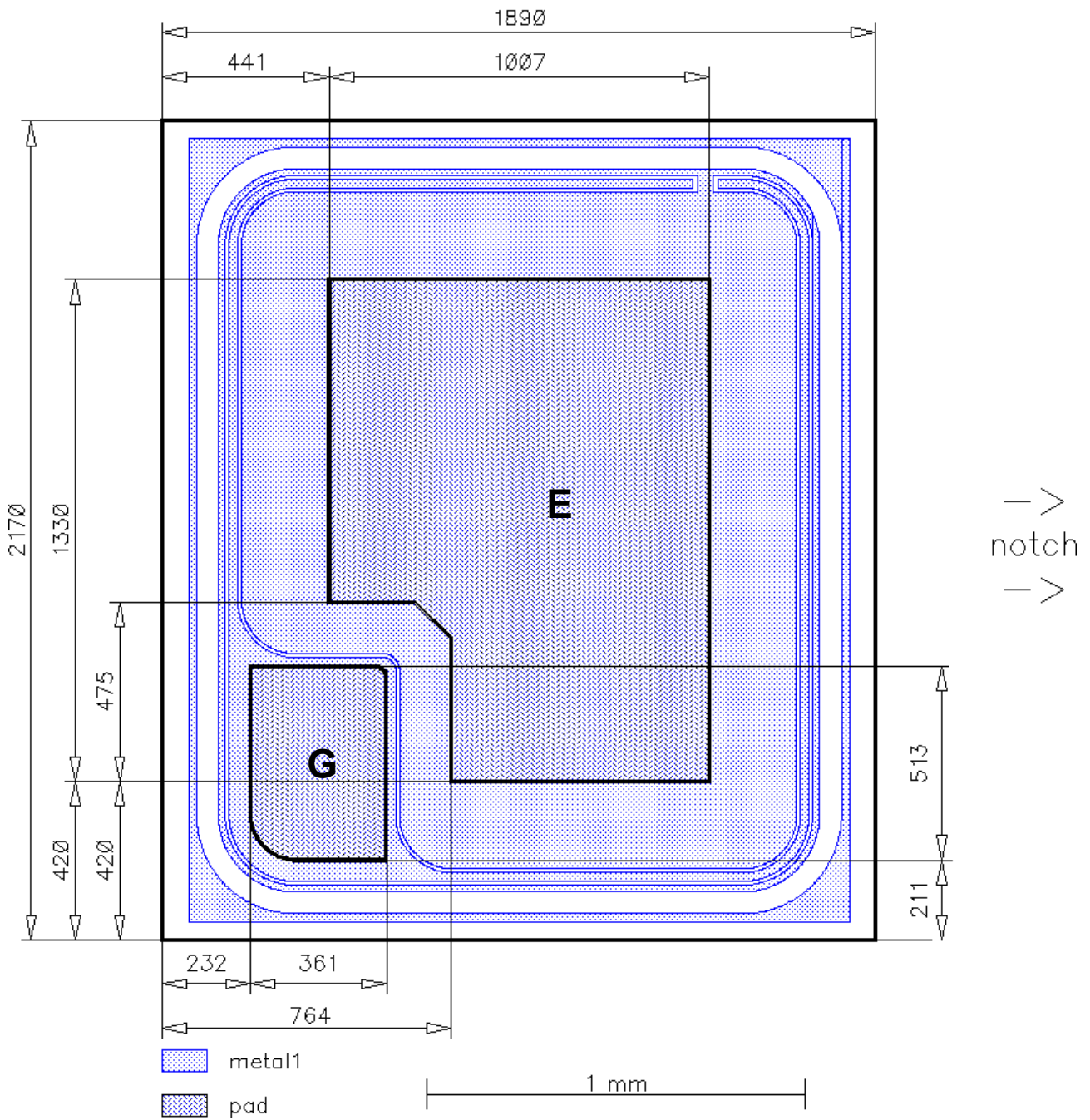
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## **Further Electrical Characteristic**

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

## Chip Drawing

Die-Size 1890  $\mu\text{m}$  x 2170  $\mu\text{m}$



**E** = Emitter  
**G** = Gate



**SIGC04T60GE**

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# SIGC04T60GE

## Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

## Revision History

Version	Subjects (major changes since last revision)	Date
2.1	Wafer diameter change to 200 mm	06.07.2010

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